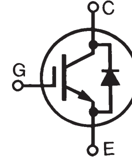
IXYS

Advance Technical Information

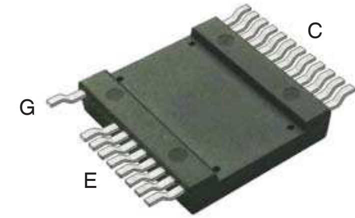
1200V XPT™ IGBT GenX3™ w/ Diode

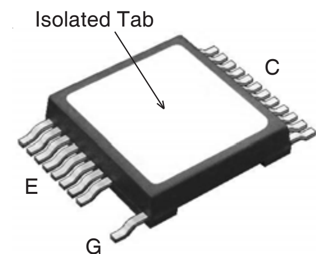
MMIX1Y82N120C3H1

V_{CES} = 1200V
I_{C110} = 36A
$V_{CE(sat)}$ ≤ 3.4V
$t_{fi(typ)}$ = 93ns



High-Speed IGBT
for 20-50 kHz Switching





G = Gate E = Emitter
C = Collector

Symbol	Test Conditions	Maximum Ratings	
V_{CES}	T_J = 25°C to 150°C	1200	V
V_{CGR}	T_J = 25°C to 150°C, R_{GE} = 1MΩ	1200	V
V_{GES}	Continuous	±20	V
V_{GEM}	Transient	±30	V
I_{C25}	T_C = 25°C	78	A
I_{C110}	T_C = 110°C	36	A
I_{F110}	T_C = 110°C	34	A
I_{CM}	T_C = 25°C, 1ms	320	A
I_A	T_C = 25°C	41	A
E_{AS}	T_C = 25°C	800	mJ
SSOA (RBSOA)	V_{GE} = 15V, T_{VJ} = 125°C, R_G = 1Ω Clamped Inductive Load	I_{CM} = 164 @V_{CE} ≤ V_{CES}	A
P_C	T_C = 25°C	320	W
T_J		-55 ... +150	°C
T_{JM}		150	°C
T_{stg}		-55 ... +150	°C
T_L	Maximum Lead Temperature for Soldering	300	°C
T_{SOLD}	1.6 mm (0.062 in.) from Case for 10	260	°C
V_{ISOL}	50/60Hz, 1 minute	2500	V~
F_C	Mounting Force	50..200/11..45	N/lb.
Weight		8	g

Symbol	Test Conditions (T_J = 25°C, Unless Otherwise Specified)	Characteristic Values Min.	Typ.	Max.	
BV_{CES}	I_C = 250μA, V_{GE} = 0V	1200			V
$V_{GE(th)}$	I_C = 250μA, V_{CE} = V_{GE}	3.0		5.0	V
I_{CES}	V_{CE} = V_{CES}, V_{GE} = 0V			50	μA
	Note 2, T_J = 125°C			3	mA
I_{GES}	V_{CE} = 0V, V_{GE} = ±20V			±100	nA
$V_{CE(sat)}$	I_C = 82A, V_{GE} = 15V, Note 1		2.9	3.4	V
	T_J = 125°C		3.5		V

Features

- Optimized for Low Switching Losses
- Silicon Chip on Direct-Copper Bond (DCB) Substrate
- Isolated Mounting Surface
- 2500V~ Electrical Isolation
- Square RBSOA
- Isolation Voltage 2500V~
- Anti-Parallel Ultra Fast Diode
- Positive Thermal Coefficient of Vce(sat)
- Avalanche Rated
- High Current Handling Capability
- International Standard Package

Advantages

- High Power Density
- Low Gate Drive Requirement

Applications

- High Frequency Power Inverters
- UPS
- Motor Drives
- SMPS
- PFC Circuits
- Battery Chargers
- Welding Machines
- Lamp Ballasts

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Symbol	Test Conditions (T_J = 25°C Unless Otherwise Specified)	Min.	Typ.	Max.	
g_{fs}	I_C = 60A, V_{CE} = 10V, Note 1	30	50		S
C_{ies}	V_{CE} = 25V, V_{GE} = 0V, f = 1MHz		4060		pF
C_{oes}			285		pF
C_{res}			110		pF
$Q_{g(on)}$	I_C = 82A, V_{GE} = 15V, V_{CE} = 0.5 • V_{CES}		215		nC
Q_{ge}			26		nC
Q_{gc}			84		nC
$t_{d(on)}$	**Inductive load, T_J = 25°C**		29		ns
t_{ri}	I_C = 80A, V_{GE} = 15V		78		ns
E_{on}	V_{CE} = 0.5 • V_{CES}, R_G = 2Ω		4.95		mJ
$t_{d(off)}$	Note 3		192	280	ns
t_{fi}			93		ns
E_{off}			2.78	5.00	mJ
$t_{d(on)}$	**Inductive load, T_J = 125°C**		29		ns
t_{ri}	I_C = 80A, V_{GE} = 15V		90		ns
E_{on}	V_{CE} = 0.5 • V_{CES}, R_G = 2Ω		7.45		mJ
$t_{d(off)}$	Note 3		200		ns
t_{fi}			95		ns
E_{off}			3.70		mJ
R_{thJC}				0.39	°C/W
R_{thCS}			0.05		°C/W
R_{thJA}			30		°C/W

Reverse Diode (Sonic-FRD)

Symbol	Test Conditions (T_J = 25°C, Unless Otherwise Specified)	Min.	Typ.	Max.	
V_F	I_F = 60A, V_{GE} = 0V, Note 1			2.7	V
	T_J = 125°C		1.9		V
I_{RM}	I_F = 60A, V_{GE} = 0V, T_J = 125°C		41		A
t_{rr}	$-di_F/dt$ = 700A/μs, V_R = 600V		420		ns
R_{thJC}				0.54	°C/W

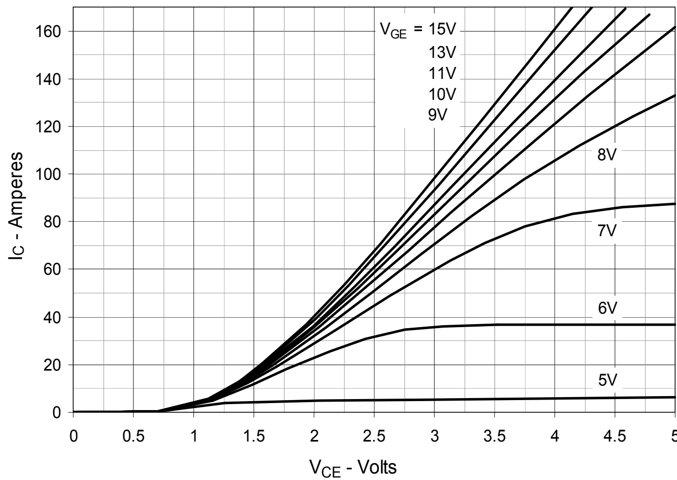
Notes:
1. Pulse test, t ≤ 300μs, duty cycle, d ≤ 2%.
2. Part must be heatsunk for high-temp I_{CES} measurement.
3. Switching times & energy losses may increase for higher V_{CE}(Clamp), T_J or R_G.

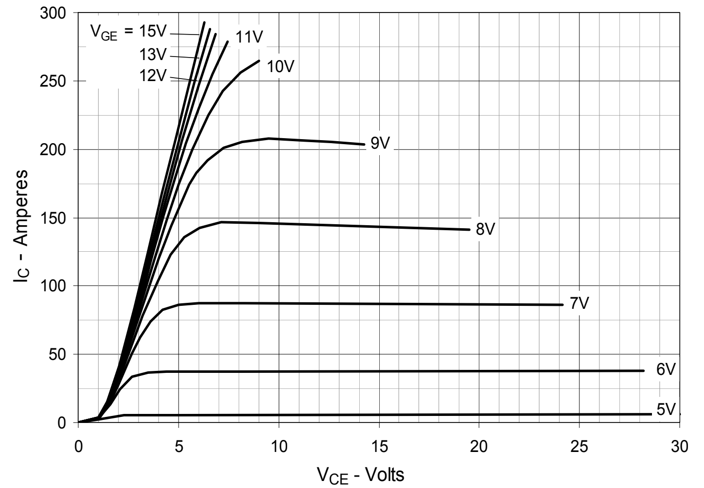
ADVANCE TECHNICAL INFORMATION

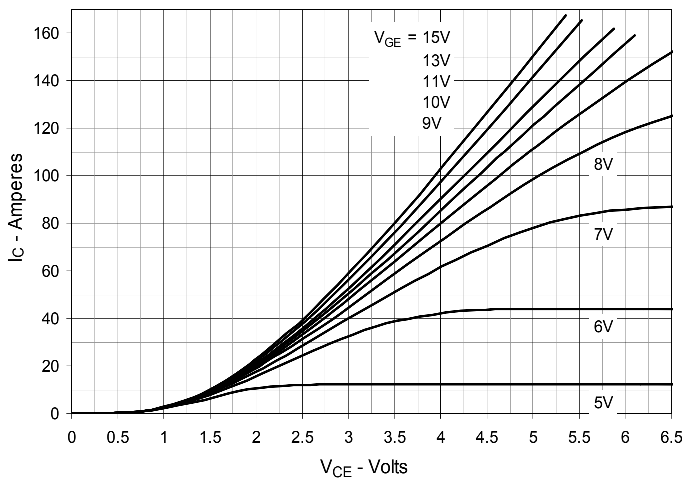
The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

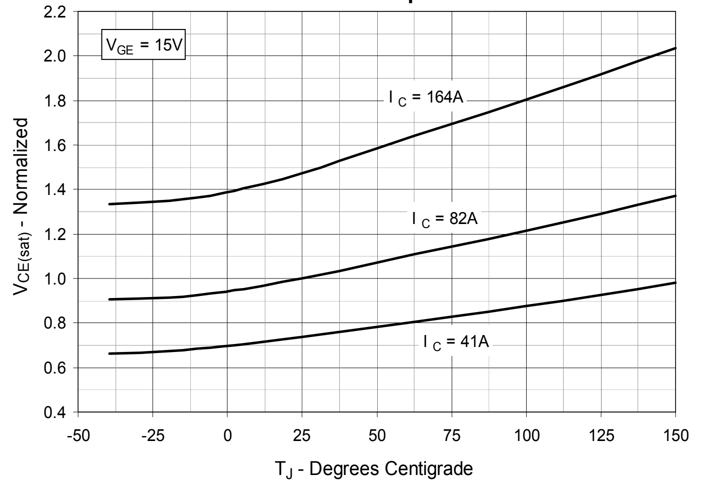
IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.

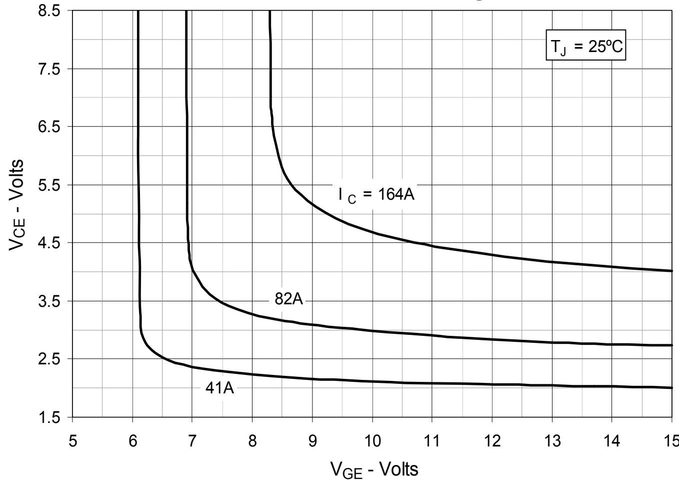
IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 7,157,338B2 4,860,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537

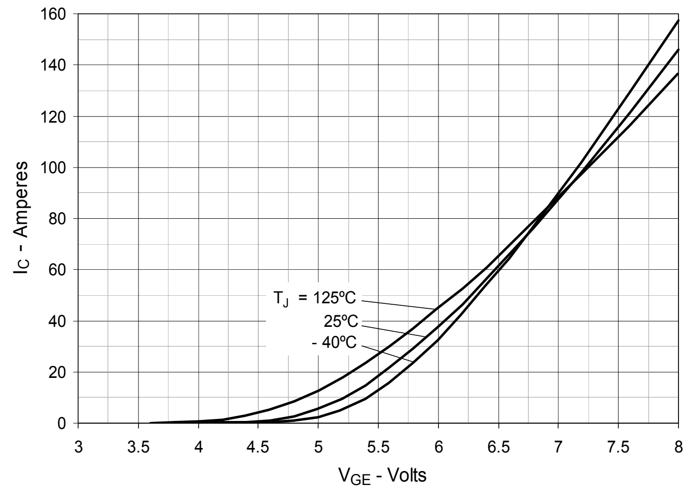












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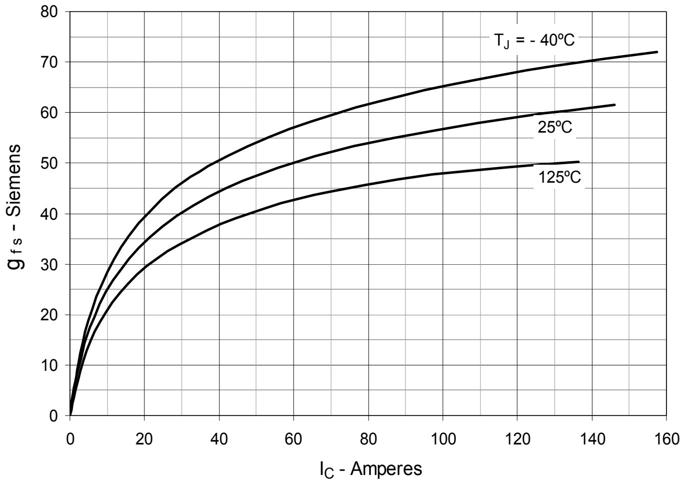

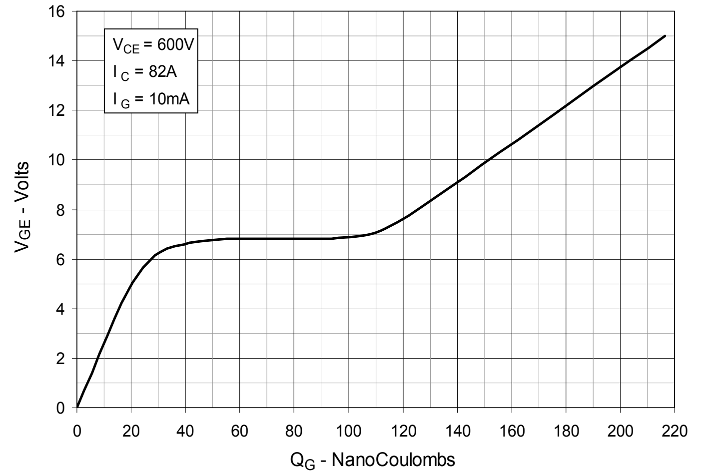

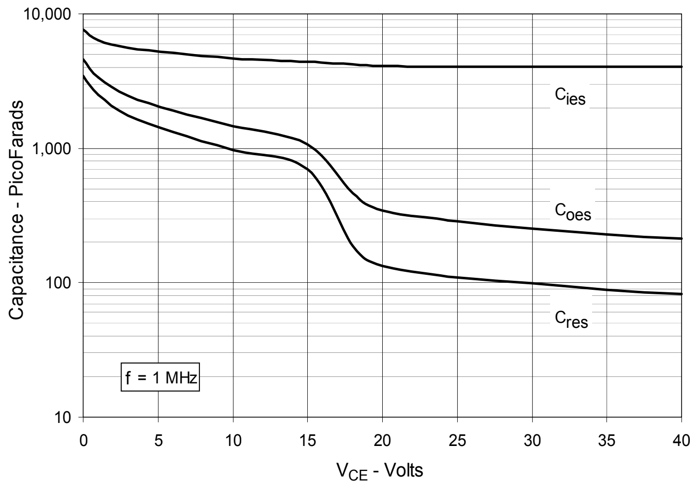

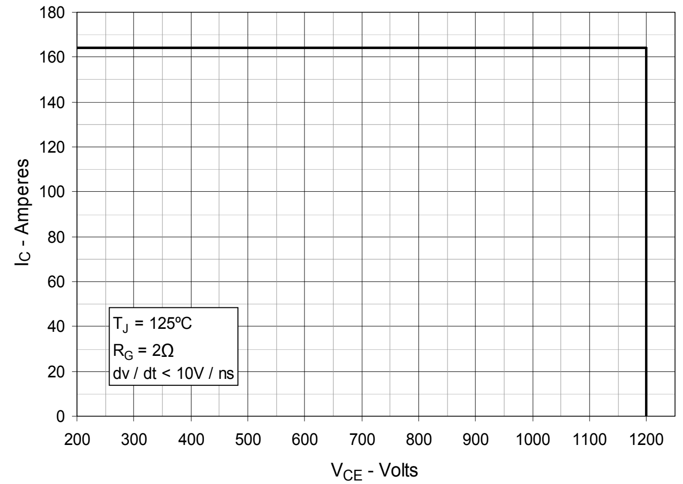

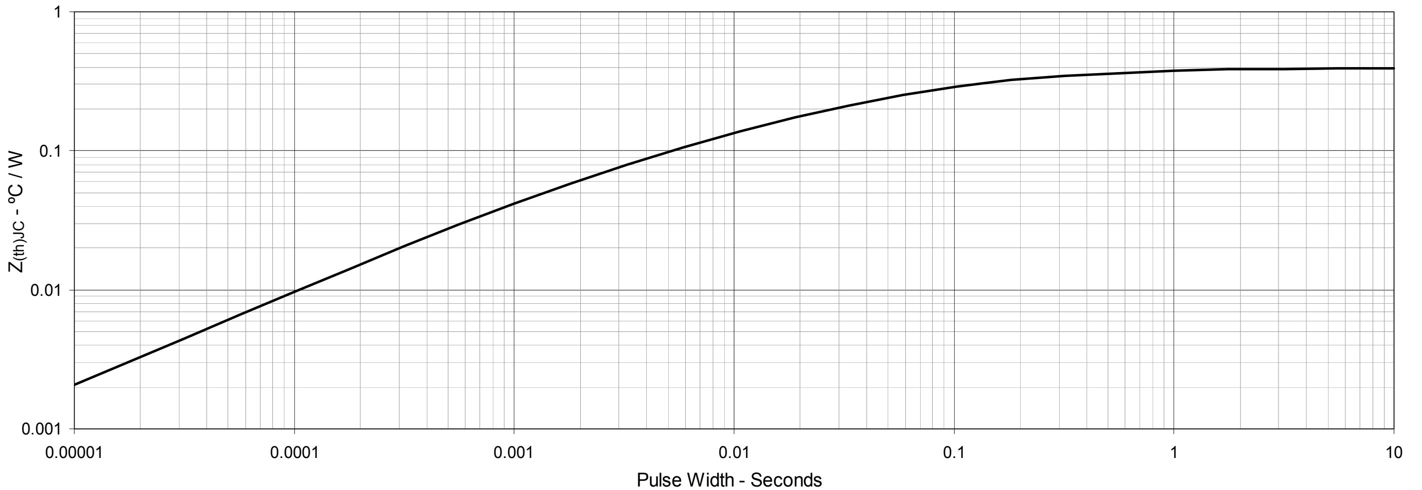

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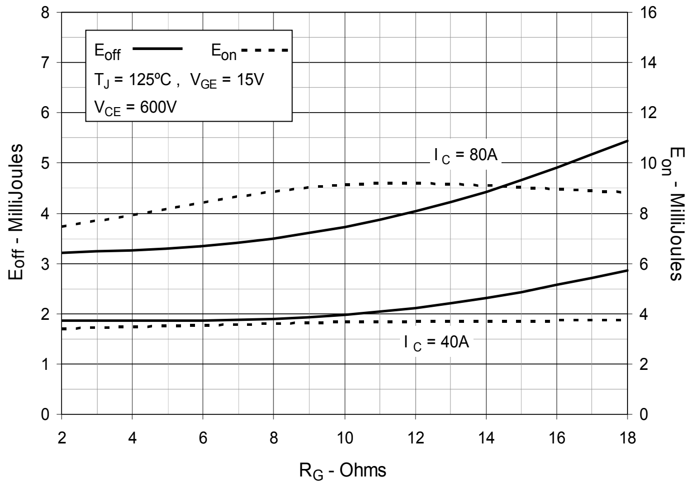

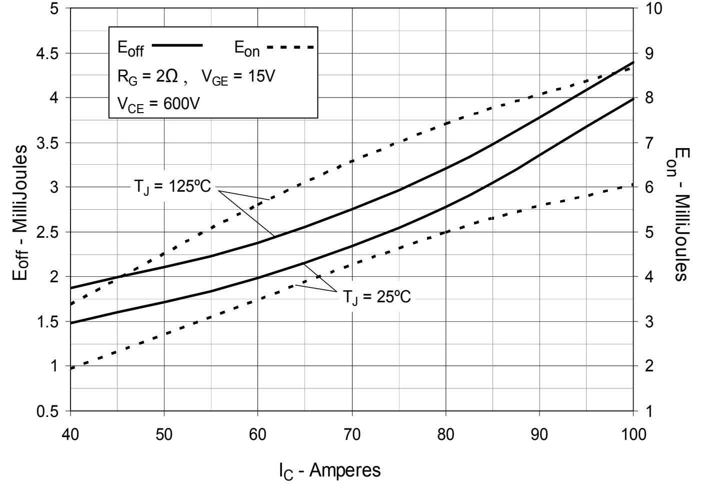

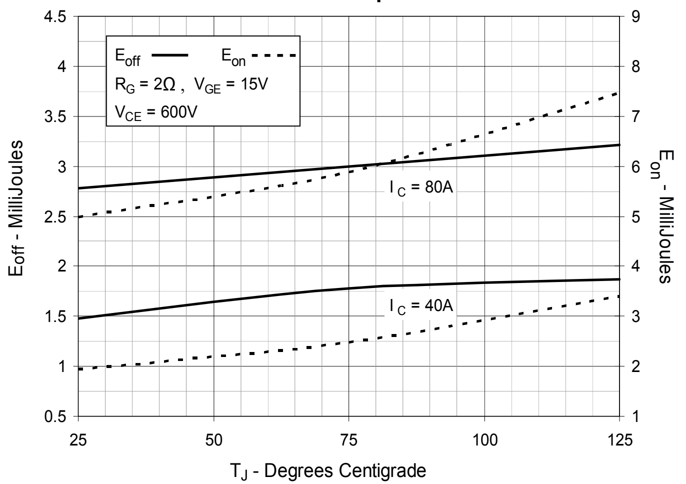

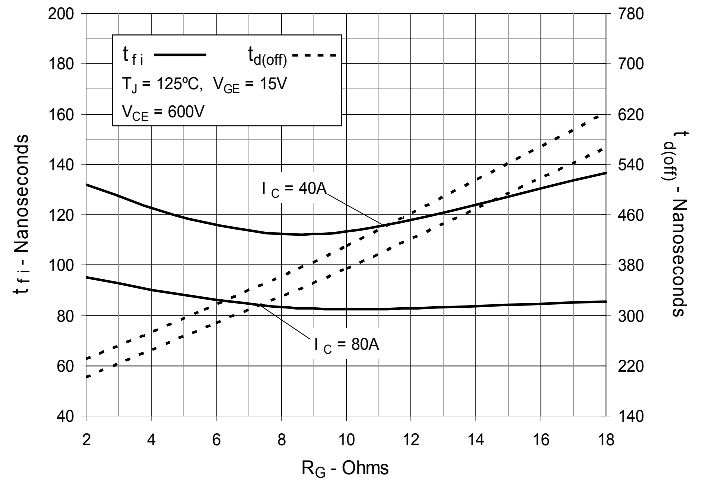

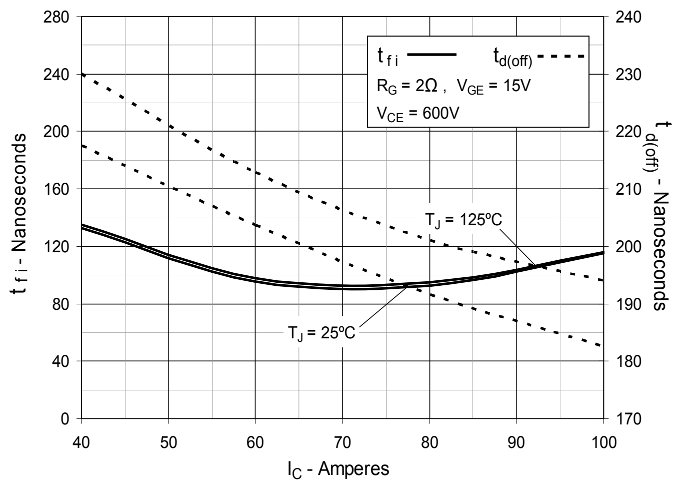

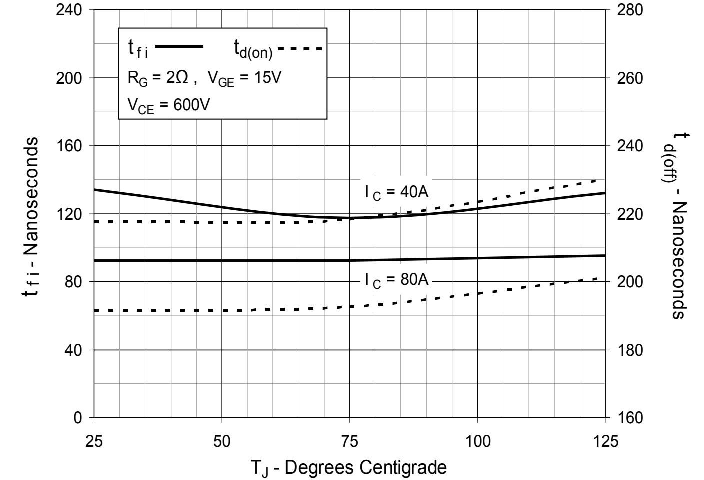

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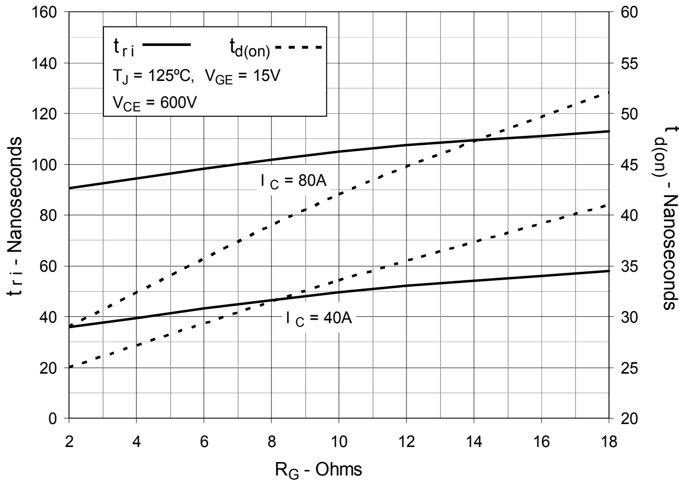

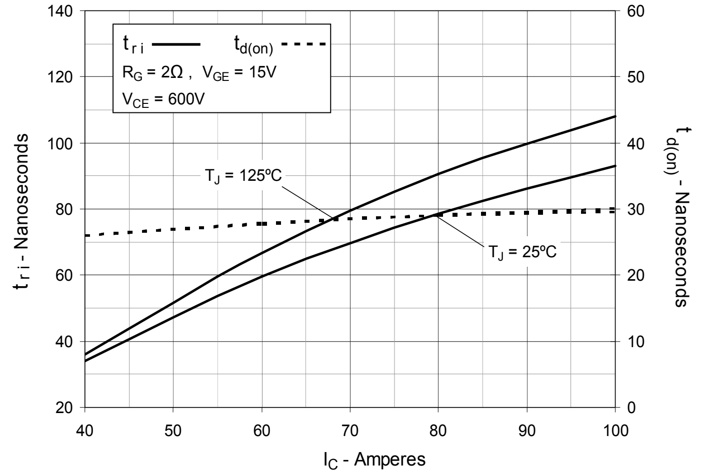

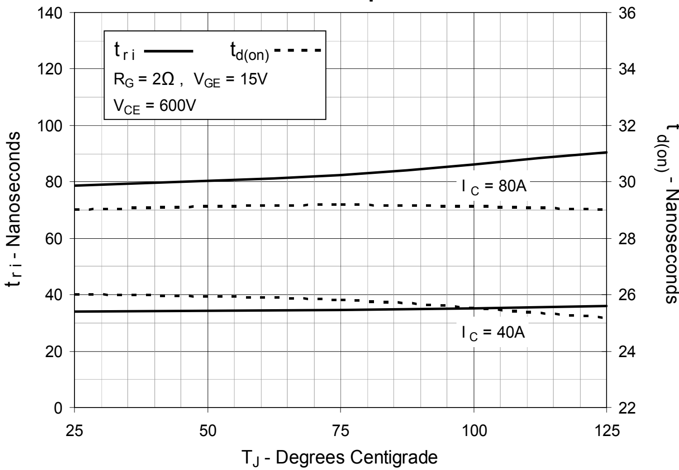

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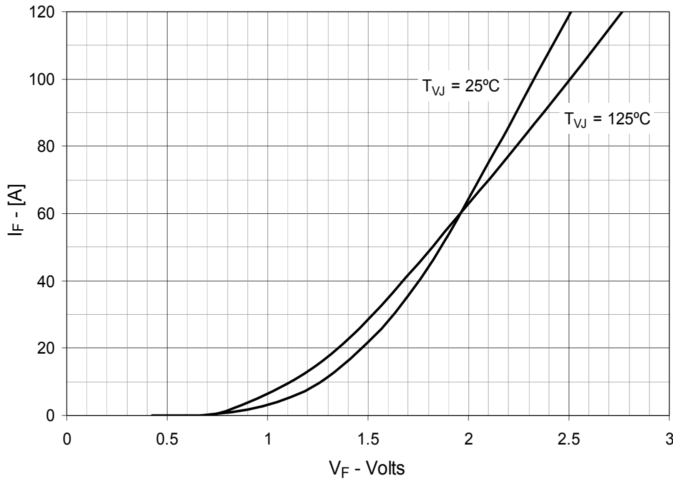

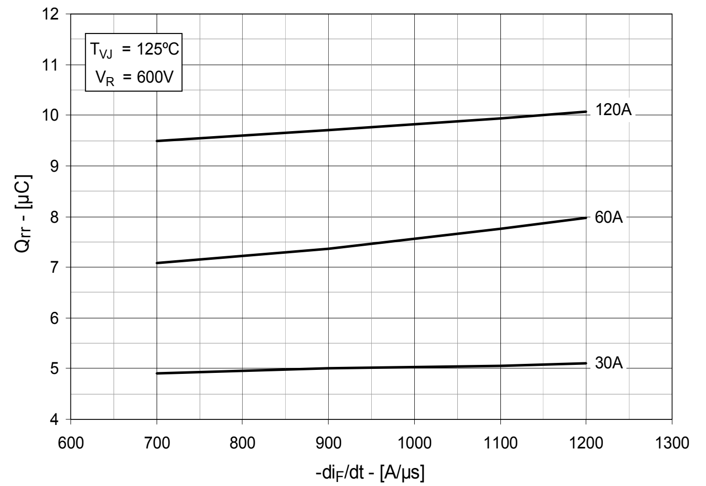

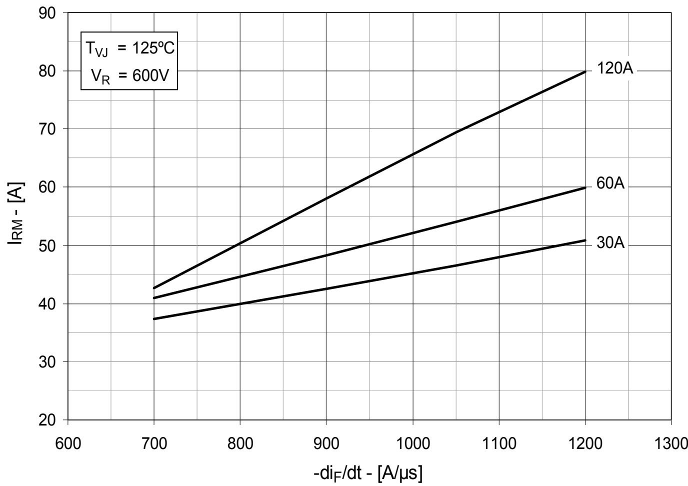

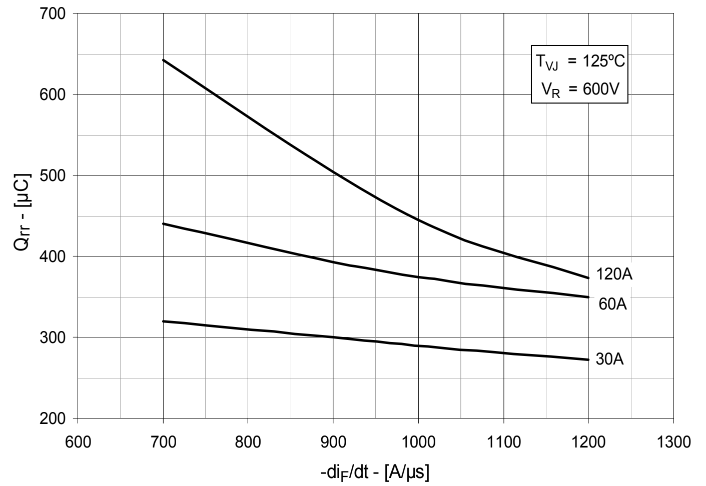

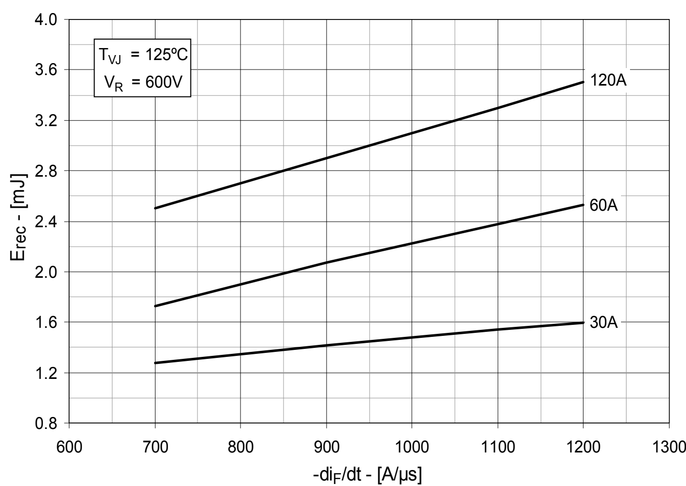

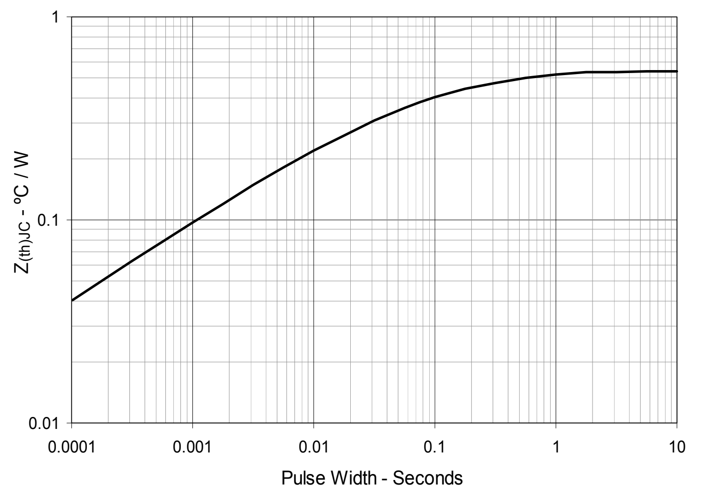

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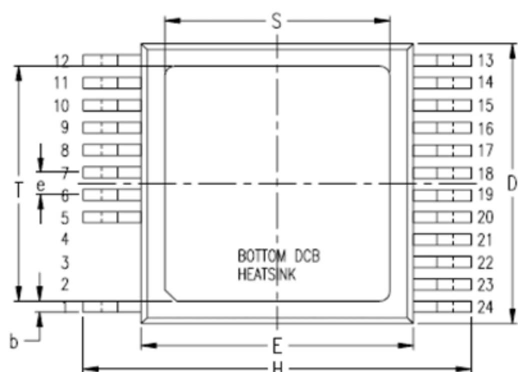

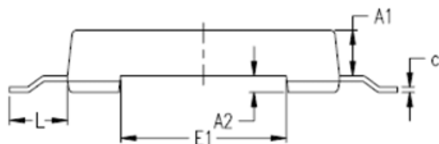

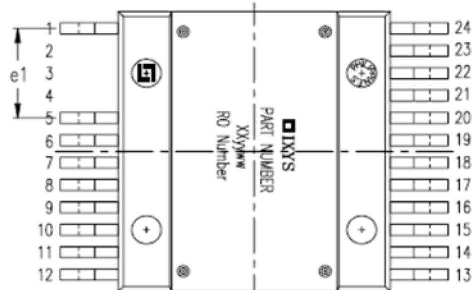

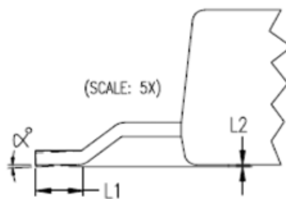

SYM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.209	.224	5.30	5.70
A1	.154	.161	3.90	4.10
A2	.055	.063	1.40	1.60
b	.035	.045	0.90	1.15
c	.018	.026	0.45	0.65
D	.976	.994	24.80	25.25
E	.898	.915	22.80	23.25
E1	.543	.559	13.80	14.20
e	.079 BSC		2.00 BSC	
e1	.315 BSC		8.00 BSC	
H	1.272	1.311	32.30	33.30
L	.181	.209	4.60	5.30
L1	.051	.067	1.30	1.70
L2	.000	.006	0.00	0.15
S	.736	.760	18.70	19.30
T	.815	.839	20.70	21.30
α	0	4°	0	4°

PIN: **1 = Gate**
5-12 = Emitter
13-24 = Collector

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